

March 2015

600 V, 40 A Field Stop IGBT

Features

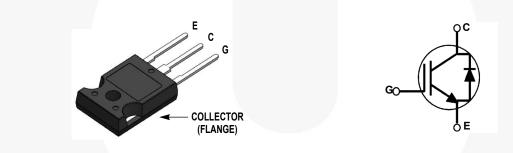
- · High Current Capability
- Low Saturation Voltage: V_{CE(sat)} = 1.8 V @ I_C = 40 A
- High Input Impedance
- · Fast Switching
- RoHS Compliant

Applications

· Solar Inverter, UPS, Welder, PFC, Microwave Oven, Telecom, ESS

General Description

Using novel field stop IGBT technology, Fairchild's field stop IGBTs offer the optimum performance for solar inverter, UPS, welder, microwave oven, telecom, ESS and PFC applications where low conduction and switching losses are essential.



Absolute Maximum Ratings

Symbol	Description		Ratings	Unit
V _{CES}	Collector to Emitter Voltage		600	V
V _{GES}	Gate to Emitter Voltage	± 20	V	
	Transient Gate-to-Emitter Voltage		± 30	V
Ι _C	Collector Current	@ T _C = 25°C	80	А
	Collector Current	@ T _C = 100 ^o C	40	А
I _{CM (1)}	Pulsed Collector Current	@ T _C = 25°C	120	А
P _D	Maximum Power Dissipation	@ T _C = 25°C	290	W
	Maximum Power Dissipation	@ T _C = 100 ^o C	116	W
TJ	Operating Junction Temperature		-55 to +150	°C
T _{stg}	Storage Temperature Range		-55 to +150	
Τ _L	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds		300	°C

Notes: 1: Repetitive rating: Pulse width limited by max. junction temperature

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
R _{0JC} (IGBT)	Thermal Resistance, Junction to Case	-	0.43	°C/W
$R_{\theta JC}$ (Diode)	Thermal Resistance, Junction to Case	-	1.45	°C/W
R _{θJA}	Thermal Resistance, Junction to Ambient	-	40	°C/W

Т
Q
ř
ð
Z
9
Ĕ
Ŧ
1
00
õ
<
-
40
⊳
-
Field
Ĭ
4.
Sto
0
IGB
ω
-

Part NumberTop MarkPackageFGH40N60UFDTUFGH40N60UFDTO-247		Top Mark	Package	Packing Method	Reel Size	Tape Width		Quantity
		TO-247	Tube	N/A	N/A		30	
Electrica	al Cha	aracteristics	of the IG	BT T _C = 25°C unless other	wise noted			
Symbol		Parameter		Test Condition	ns Min.	Тур.	Max.	Unit
Off Charact	teristics							
BV _{CES}	Collecto	r to Emitter Breakdo	own Voltage	V _{GE} = 0 V, I _C = 250 μA	600	_	-	V
$\frac{\Delta BV_{CES}}{\Delta T_{J}}$	Collector to Emitter Breakdown Voltage Temperature Coefficient of Breakdown Voltage		Proakdown	V _{GE} = 0 V, I _C = 250 μA	-	0.6	-	V/ºC
I _{CES}	Collecto	r Cut-Off Current		V _{CE} = V _{CES} , V _{GE} = 0 V	-	-	250	μA
I _{GES}	G-E Lea	kage Current		$V_{GE} = V_{GES}, V_{CE} = 0 V$	-	-	±400	nA
					I			
On Charact								
V _{GE(th)}	G-E Thr	eshold Voltage		$I_C = 250 \ \mu A, \ V_{CE} = V_{GE}$	4.0	5.0	6.5	V
Varia	Collecto	or to Emittor Saturation Voltago		I _C = 40 A, V _{GE} = 15 V	-	1.8	2.4	V
V _{CE(sat)}	Collector to Emitter Saturation Voltage			I _C = 40 A, V _{GE} = 15 V, T _C = 125 ^o C	-	2.0	-	V
Dynamic C	haracter	istics						
C _{ies}	Input Ca	apacitance			-	2110	-	pF
C _{oes}	Output (Capacitance		V _{CE} = 30 V _, V _{GE} = 0 V, f = 1 MHz	-	200	-	pF
C _{res}	Reverse Transfer Capacitance				-	60	-	pF
Switching (Characte	ristics						
t _{d(on)}	Turn-On Delay Time Rise Time				-	24	-	ns
t _r					-	44	-	ns
t _{d(off)}	Turn-Of	Furn-Off Delay Time Fall Time Furn-On Switching Loss Furn-Off Switching Loss		V _{CC} = 400 V, I _C = 40 A,	-	112	-	ns
t _f	Fall Tim			$R_{G} = 10 \Omega, V_{GE} = 15 V,$	-	30	60	ns
E _{on}	Turn-Or			Inductive Load, $T_C = 25^{\circ}$	C -	1.19	-	mJ
E _{off}	Turn-Of				-	0.46	- 1	mJ
E _{ts}	Total Sv	vitching Loss			-	1.65	-	mJ
t _{d(on)}	Turn-Or	Delay Time			-	24	-	ns
t _r	Rise Tin	Rise Time			-	45	-	ns
t _{d(off)}	Turn-Of	f Delay Time		V _{CC} = 400 V, I _C = 40 A,	-	120	-	ns
t _f	Fall Tim	I Time rn-On Switching Loss rn-Off Switching Loss		$R_{G} = 10 \Omega, V_{GE} = 15 V,$		40	-	ns
E _{on}	Turn-Or			Inductive Load, $T_C = 125$	-	1.2	-	mJ
E _{off}	Turn-Of				-	0.69	-	mJ
E _{ts}	Total Sv	vitching Loss			-	1.89	-	mJ
Qg	Total Ga	ate Charge			-	120	-	nC
Q _{ge}	Gate to	Emitter Charge		V _{CE} = 400 V, I _C = 40 A, V _{GE} = 15 V	-	14	-	nC
Q _{gc}	Gate to	Gate to Collector Charge		GE - IO V	_	58	-	nC

5	Min.	Тур.	Max	Unit	
Г _С = 25 ^о С	-	1.95	2.6	v	
Г _С = 125 ^о С	-	1.85	-		
Г _С = 25 ^о С	-	45	-	ns	
Г _С = 125°С	-	140	-		
Г _С = 25 ^о С	-	75	-	nC	
Г _С = 125 ^о С	-	375	-		

Electrical Characteristics of the Diode T_C = 25°C unless otherwise noted

I_F = 20 A

Parameter

Diode Reverse Recovery Time

Diode Reverse Recovery Charge

Diode Forward Voltage

Test Conditions

 $I_{\rm F}$ =20 A, di_F/dt = 200 A/µs

Symbol

 V_{FM}

t_{rr}

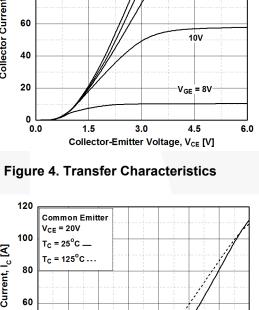
Q_{rr}

©2008 Fairchild Semiconductor Corporation
FGH40N60UFD Rev. 1.5

Typical Performance Characteristics Figure 1. Typical Output Characteristics 120 120 T_C = 125°C T_C = 25°C 15V 12V 20V 20V 100 100 Collector Current, Ic [A] Collector Current, I_c [A] 80 80 60 60 10V 40 40 20 20 $V_{GE} = 8V$ 0 0 0.0 4.5 0.0 1.5 1.5 3.0 6.0 Collector-Emitter Voltage, V_{CE} [V] **Figure 3. Typical Saturation Voltage** Characteristics 120 120 Common Emitter Common Emitter V_{CE} = 20V V_{GE} = 15V 100 100 T_C = 25^oC ___ T_C = 25°C ____ Collector Current, I_c [A] Collector Current, Ic [A] = 125[°]C ... T_C = 125[°]C Тc 80 80 60 60 40 40 20 20 0 0 3 0 2 5 6 8 1 7 Collector-Emitter Voltage, V_{CE} [V] Figure 5. Saturation Voltage vs. Case **Temperature at Variant Current Level** 3.5 Common Emitter 20 V_{GE} = 15V Collector-Emitter Voltage, V_{CE} [V] 9.1 0.7 5.7 0.6 [V] Collector-Emitter Voltage, V_{CE} [V] 80A 16 12 40A 8 I_C = 20A I_C = 20A 1.0 ٥ ^ل 25 50 75 100 125 8 Case Temperature, T_c [°C]

Figure 2. Typical Output Characteristics

15V



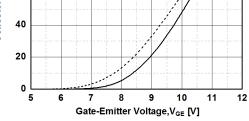
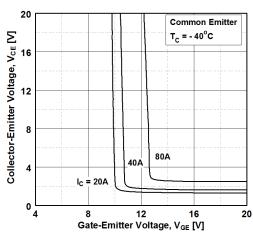


Figure 6. Saturation Voltage vs. V_{GE}



Typical Performance Characteristics



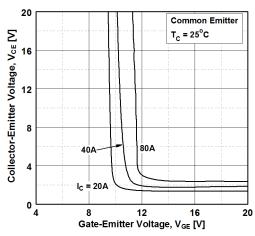
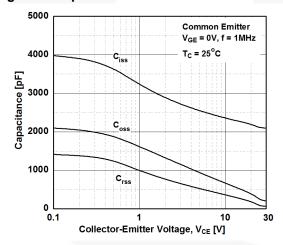


Figure 9. Capacitance Characteristics





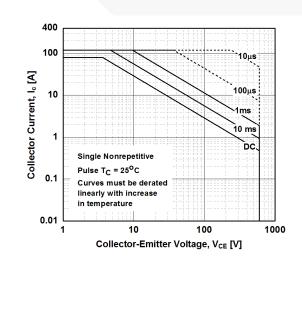


Figure 8. Saturation Voltage vs. VGE

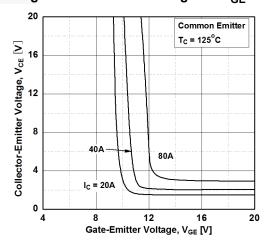


Figure 10. Gate charge Characteristics

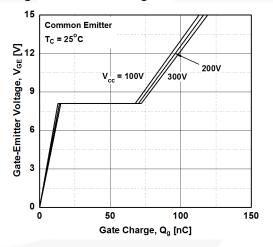
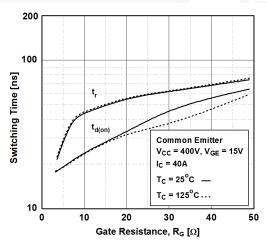
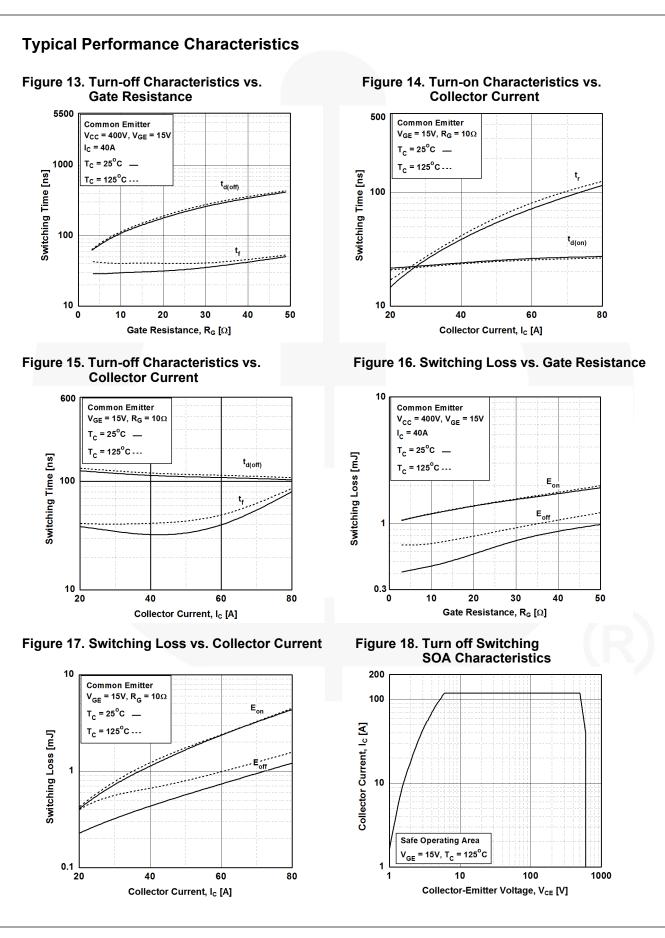
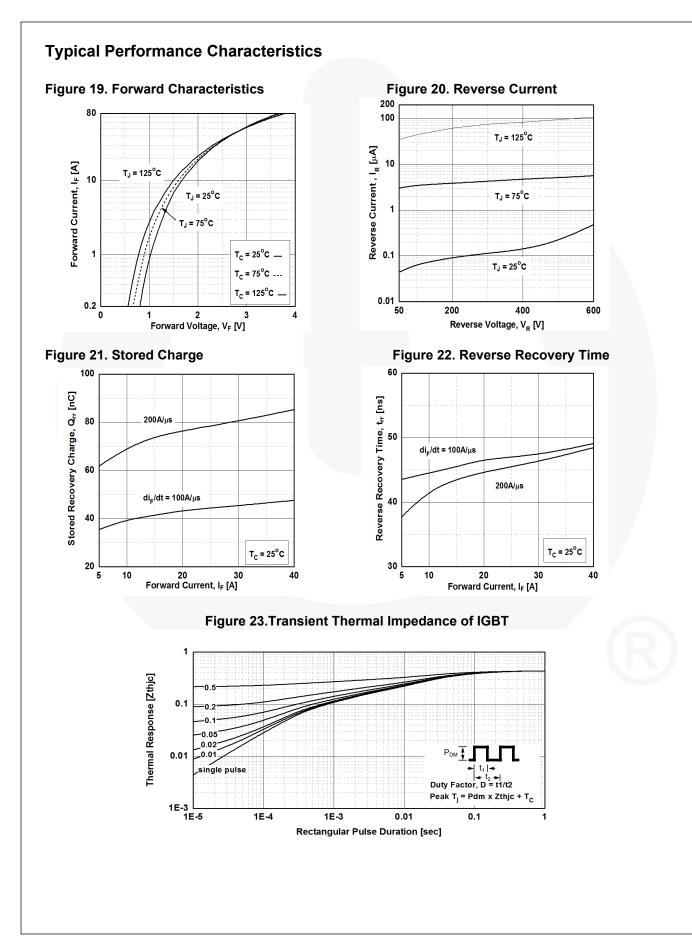
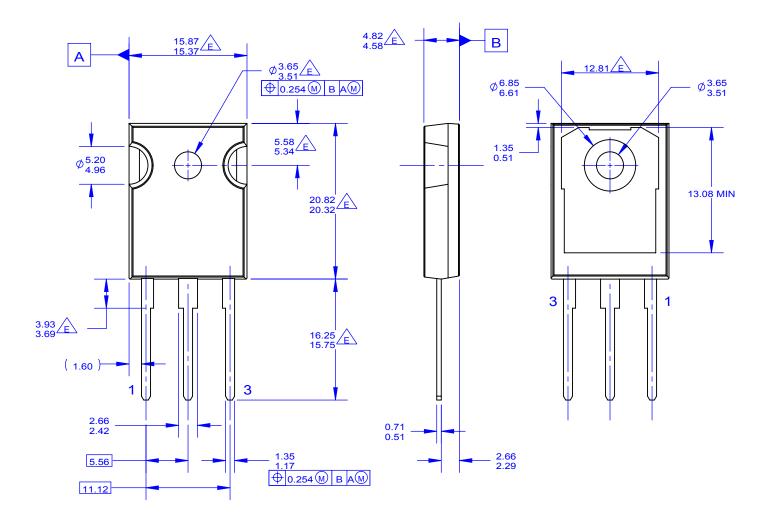


Figure 12. Turn-on Characteristics vs. Gate Resistance





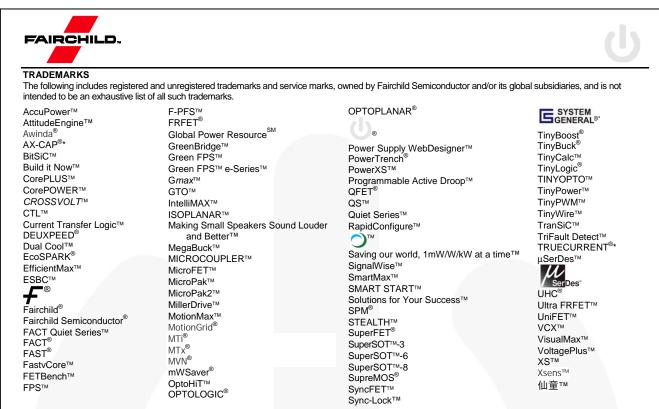




NOTES: UNLESS OTHERWISE SPECIFIED.

- A. PACKAGE REFERENCE: JEDEC TO-247, ISSUE E, VARIATION AB, DATED JUNE, 2004.B. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD
- FLASH, AND TIE BAR EXTRUSIONS.
- C. ALL DIMENSIONS ARE IN MILLIMETERS.
- D. DRAWING CONFORMS TO ASME Y14.5 1994

DOES NOT COMPLY JEDEC STANDARD VALUE F. DRAWING FILENAME: MKT-TO247A03_REV03



* Trademarks of System General Corporation, used under license by Fairchild Semiconductor.

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. TO OBTAIN THE LATEST, MOST UP-TO-DATE DATASHEET AND PRODUCT INFORMATION, VISIT OUR WEBSITE AT <u>HTTP://WWW.FAIRCHILDSEMI.COM</u>, FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

AUTHORIZED USE

Unless otherwise specified in this data sheet, this product is a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability. This product may not be used in the following applications, unless specifically approved in writing by a Fairchild officer: (1) automotive or other transportation, (2) military/aerospace, (3) any safety critical application – including life critical medical equipment – where the failure of the Fairchild product reasonably would be expected to result in personal injury, death or property damage. Customer's use of this product is subject to agreement of this Authorized Use policy. In the event of an unauthorized use of Fairchild's product, Fairchild accepts no liability in the event of product failure. In other respects, this product shall be subject to Fairchild's Worldwide Terms and Conditions of Sale, unless a separate agreement has been signed by both Parties.

ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.fairchildsemi.com, under Terms of Use

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufacturers of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed applications, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handling and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address any warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

PRODUCT STATUS DEFINITIONS

Definition of Terms					
Datasheet Identification	Product Status	Definition			
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.			
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.			
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.			
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.			

Rev. 175